

Search Notes

Application/Control No.

10/718,684

Examiner

KEVIN L. LEE

Applicant(s)/Patent under
Reexamination

MIKIYA ET AL.

Art Unit

3753

SEARCHED

Class	Subclass	Date	Examiner
137	614 614.03 614.04 614.05	9/15/2005	KL
251	149.2		
285	316		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
EAST		9/15/2005	KL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search- see search history printout	9/15/2005	KL
Interference search- see search history printout	9/15/2005	KL